

<b>Notice of References Cited</b>	Application/Control No. 10/541,090	Applicant(s)/Patent Under Reexamination TEMPLE, KIT	
	Examiner SEUNG H. LEE	Art Unit 2887	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0144939	07-2003	Stransky et al.	705/36
*	B	US-2002/0076051	06-2002	Nii, Naoaki	380/232
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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